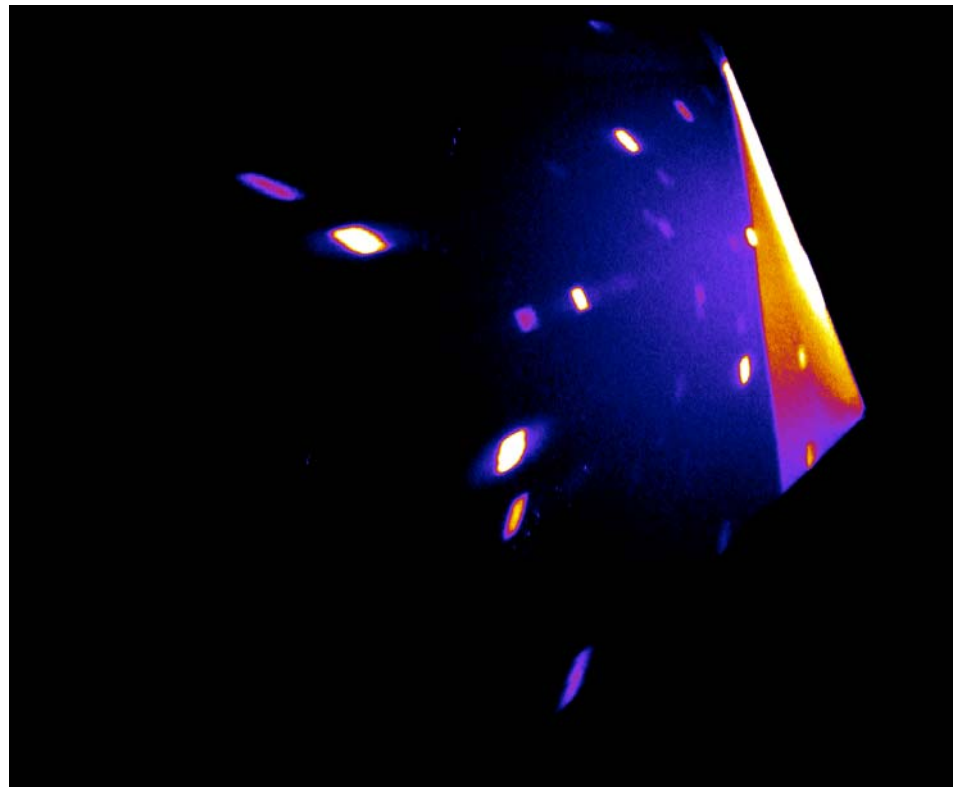




The Study of Shock Physics in single crystal Tantalum. A Target Fabrication Challenge.

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Overview

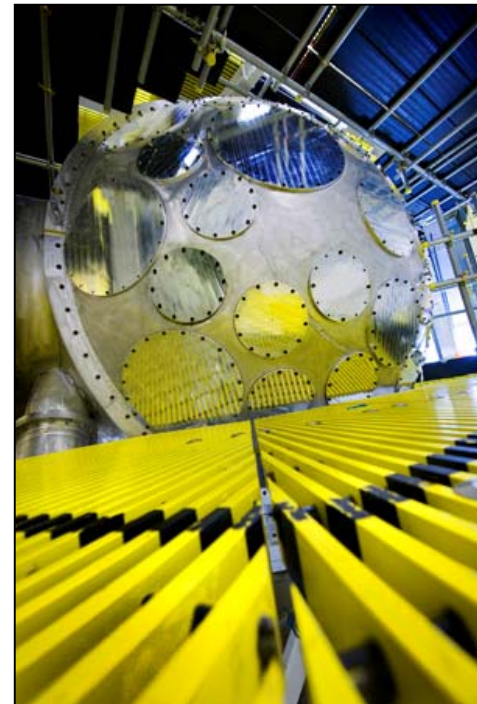
- General Introduction
- Introduction to the Laue Campaign
- Experimental Principle
- The Target
- The Components
- The Construction
- Conclusion





Introduction

- AWE Target Fabrication Group supports plasma physics experiments fielded on a number of laser systems around the world, which will soon include AWE's flagship Orion Laser.



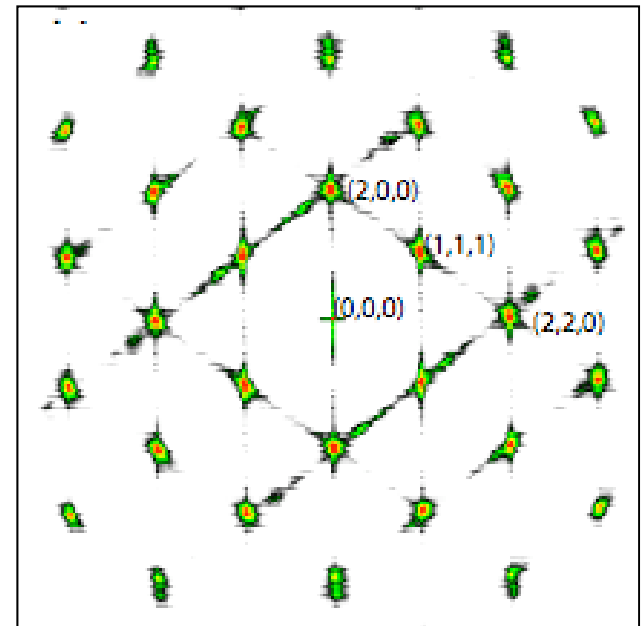


Background

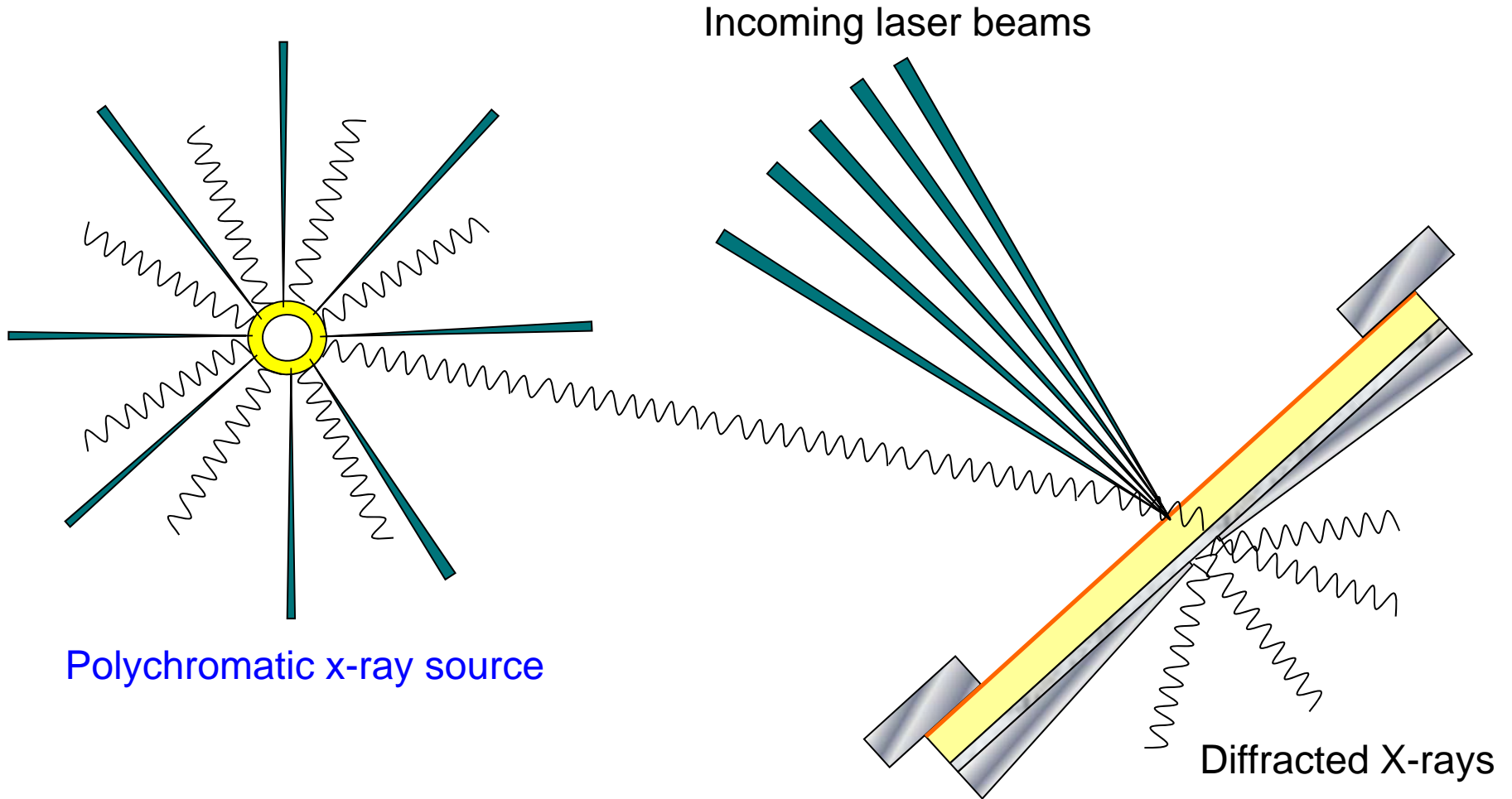
- Most laser targets need an element of:
 - Procurement,
 - R&D, manufacture,
 - Assembly and
 - Characterisation.
- What can seem like a straight forward target to the experimentalist can in fact prove quite a challenge to the fabricators.

Laue Experimental Aim

- To investigate dislocation densities in a shocked single crystal using the x-ray Laue diffraction technique.
- High rate dynamic loading in a metallic single crystal is expected to produce very large dislocation densities which should be revealed by a broadening of the spots in the Laue diffraction pattern.

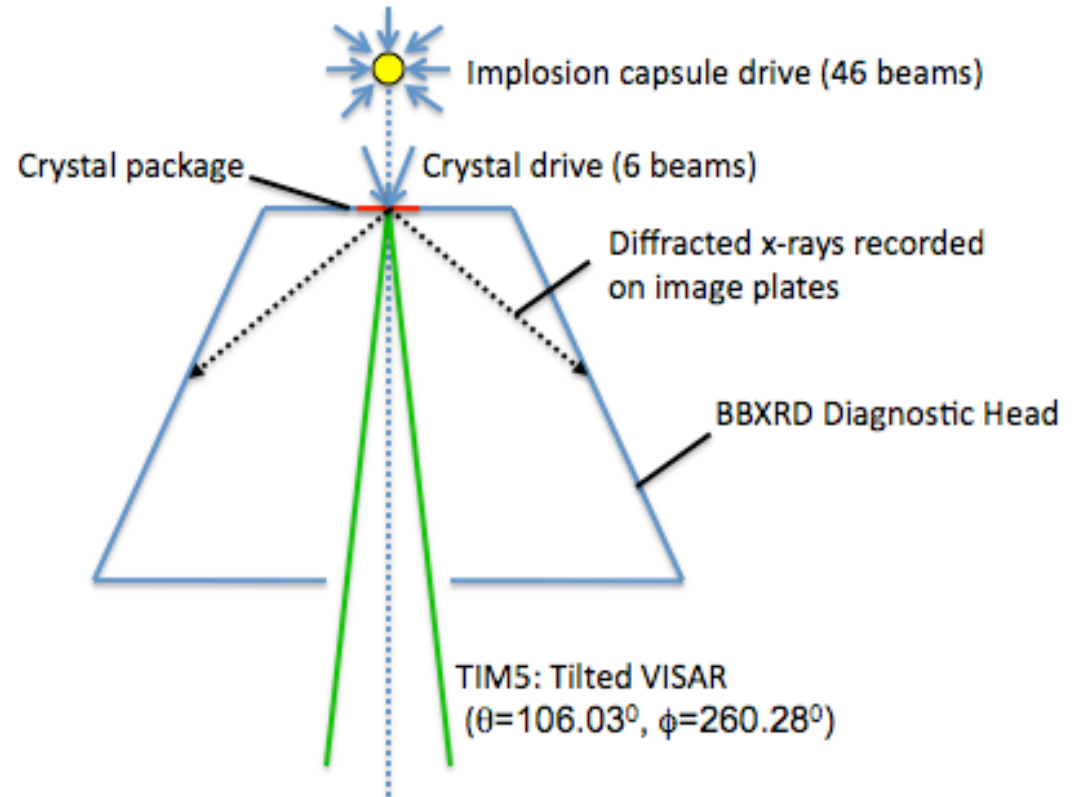


The Principle

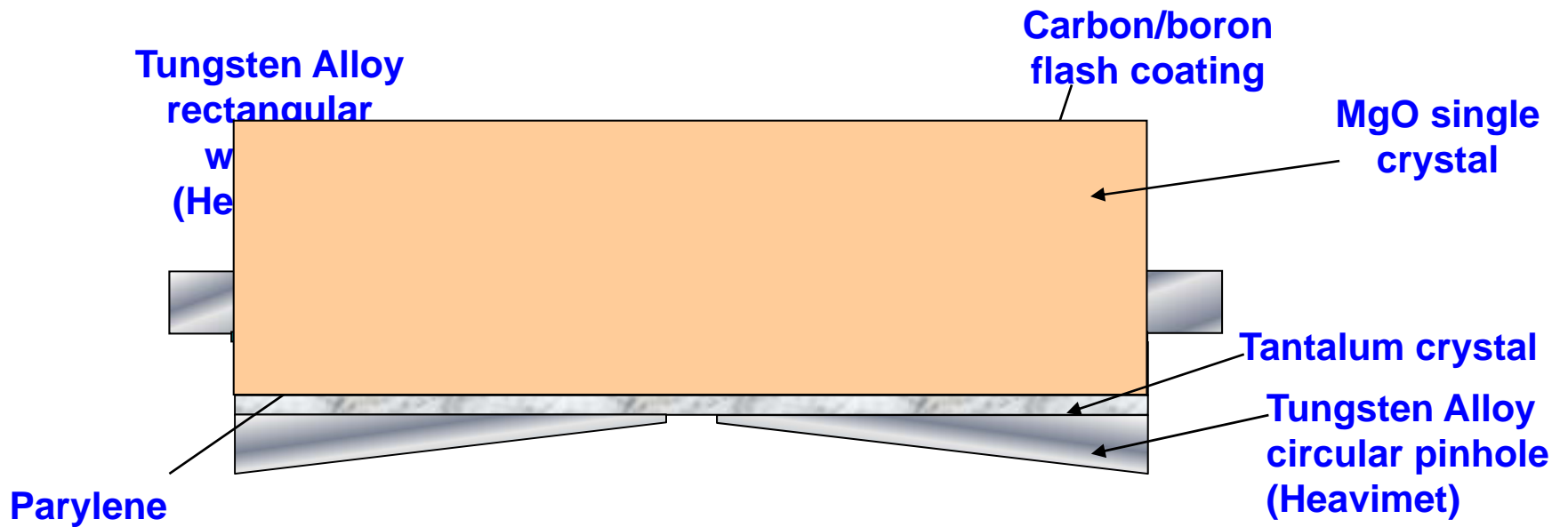


Experimental set up

- Target sits in a broad band x-ray camera.
- Camera has x-ray sensitive film on the inside to collect diffracted x-rays.



The Target





Construction – first thoughts

- Simple!
- Order a piece of single crystal foil and a pinhole.
- Glue them together.
- Coat it.
- Attach it to a washer and
- Shoot a laser at it.
- Unfortunately its not that simple.

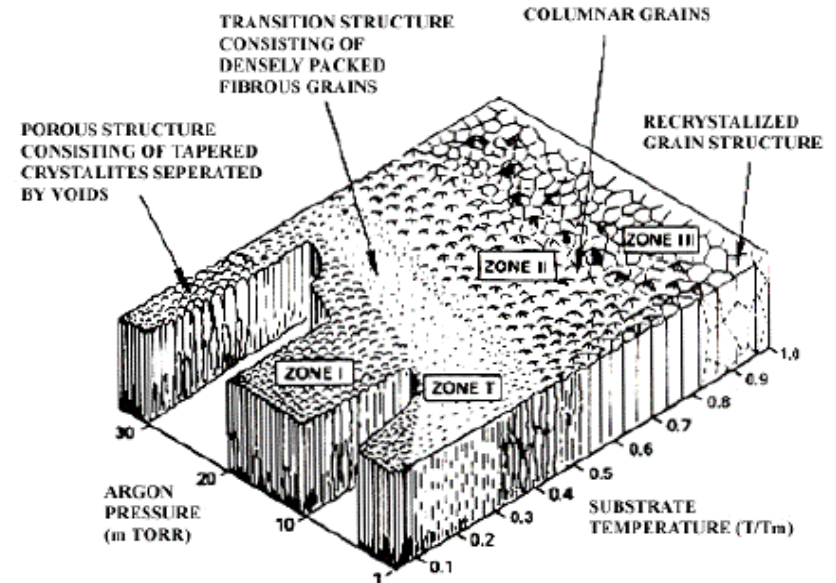
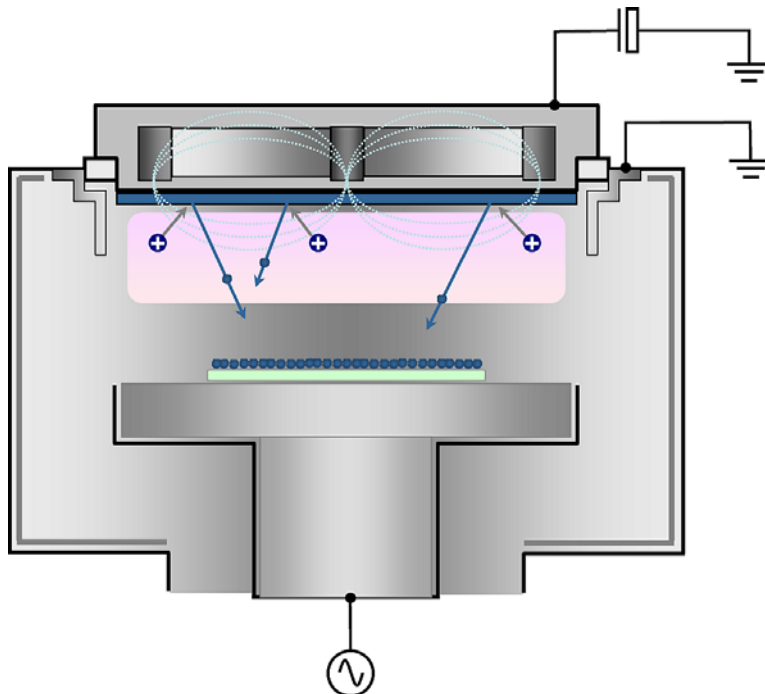


To begin with, there are the parts.

- Ta single crystal foils (on MgO).
- Heavimet circular pin holes.
- **Adhesive.**
- Heavimet rectangular washers.
- Parylene ablator.
- Boron/carbon reflector.
- CH capsules.
 - Chemicals and lab apparatus.

Single crystal tantalum foils

- Physically vapour deposited utilising an effect known as eptiaxy.



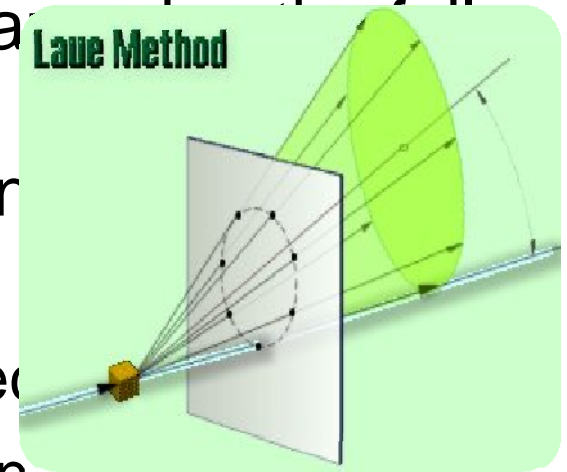


Single crystal tantalum foils

- Challenge:
 - Only one known source in the world available for producing this type of Ta foil.
 - Only one source of single crystal MgO (must be sourced from China).
 - This creates supply/time issues.

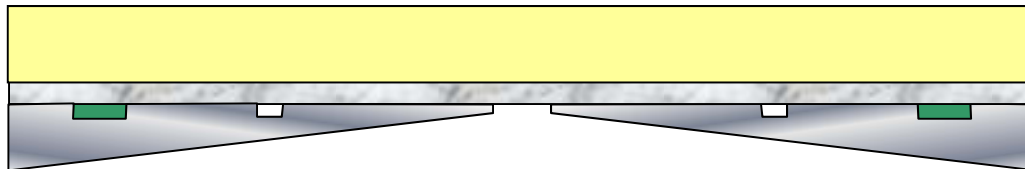
Single crystal MgO Substrate

- Ideally need to cut MgO without damage
- How?
- Must remove the MgO from the target
- Note
 - free standing Ta foils liable to defects
 - Ta foils need x-ray characterisation.



Pinholes

- Precision machined from Heavimet alloy.
- First challenge, finding a supplier who can supply, machine and characterise the parts.
- Centre must be 100 microns \pm 10 microns. Angle needs to be 170 degrees.
- Need an adhesive well and over-flow reservoir to prevent glue wicking into central hole.



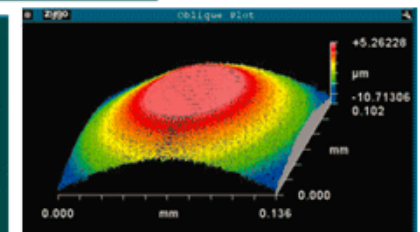
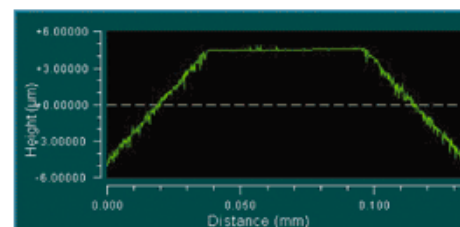
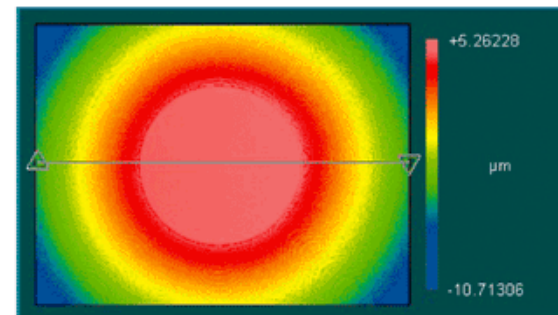
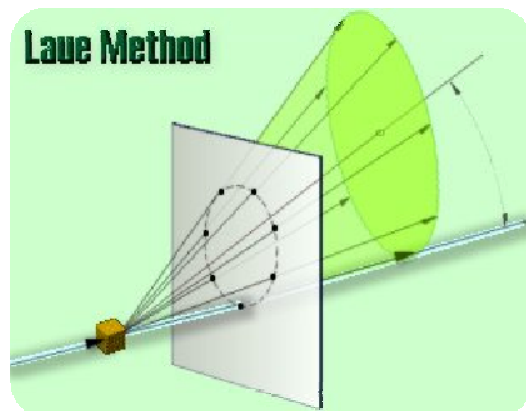


Adhesives

- Used to bond MgO backed tantalum foil to Heavimet pinhole.
- MgO removed using conc acid at elevated temperature.
- Compatibility trials are needed as no specific adhesive is manufactured for these conditions.
- Still have other usual adhesive challenges, curing wicking, sticking etc.

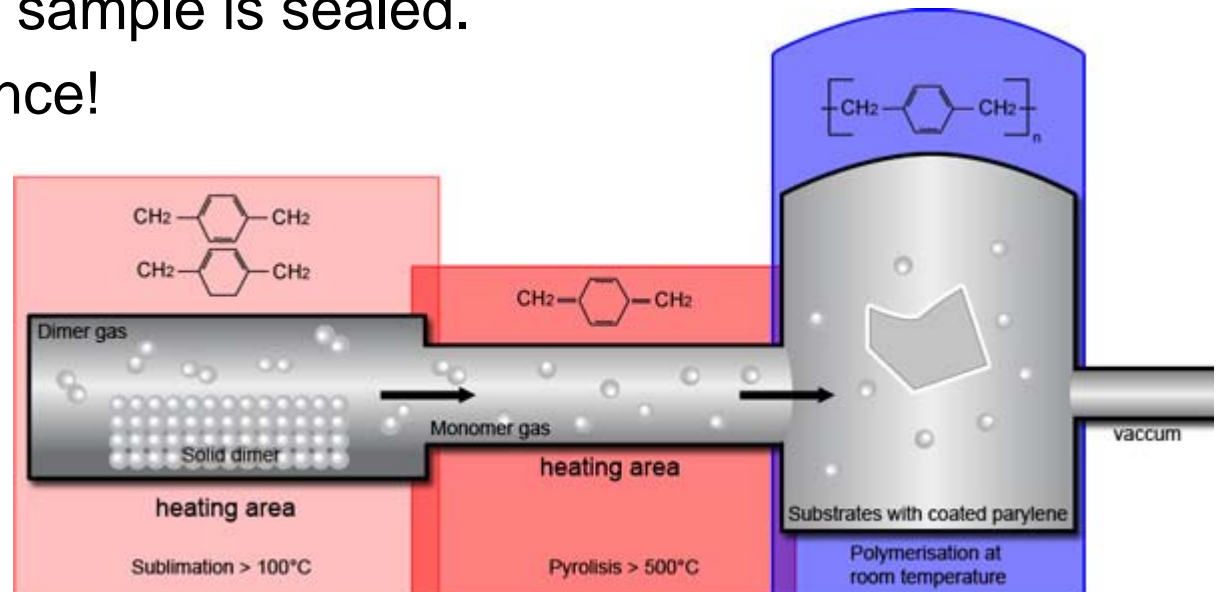
Characterisation

- Foils need to be assessed at each stage to check for damage to the foil (damage = increased defect density)
 - Laue diffraction
 - Flatness



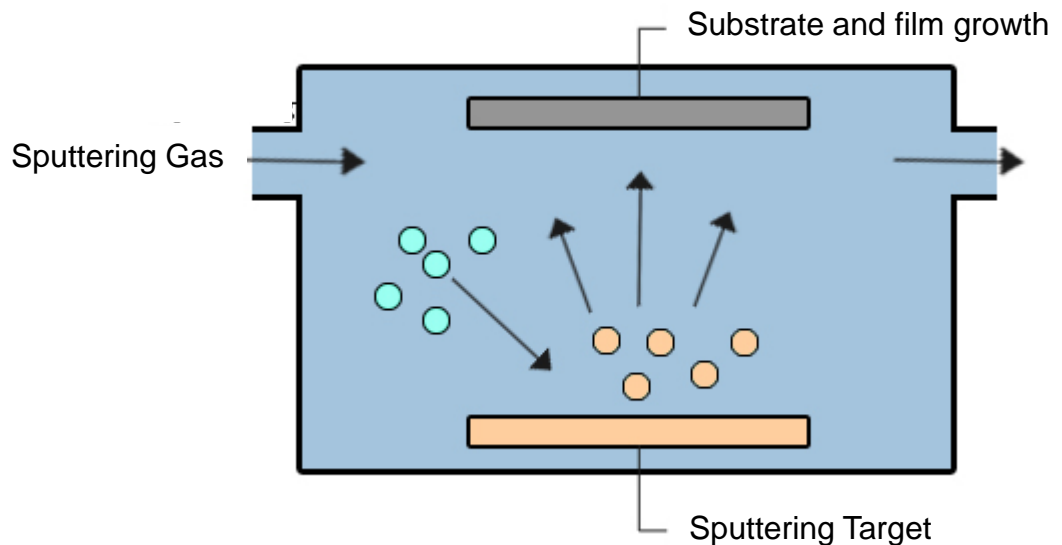
Parylene Coating (and characterisation)

- Parylene coating gets everywhere!
- Need 20 microns (2 days) on one the tantalum foil side and nothing on the reverse.
 - Need to ensure sample is sealed.
 - No second chance!



Carbon overcoat

- Less difficult as a line of sight coating process using sputter coating.
- Also only 500nm required.
- But still needs characterisation.





Assembly

- Finally, the bonded, coated and characterised foil needs to be mounted into a washer in the correct orientation.
- Transported safely to the US.
- Then all the experimental timing issues begin.

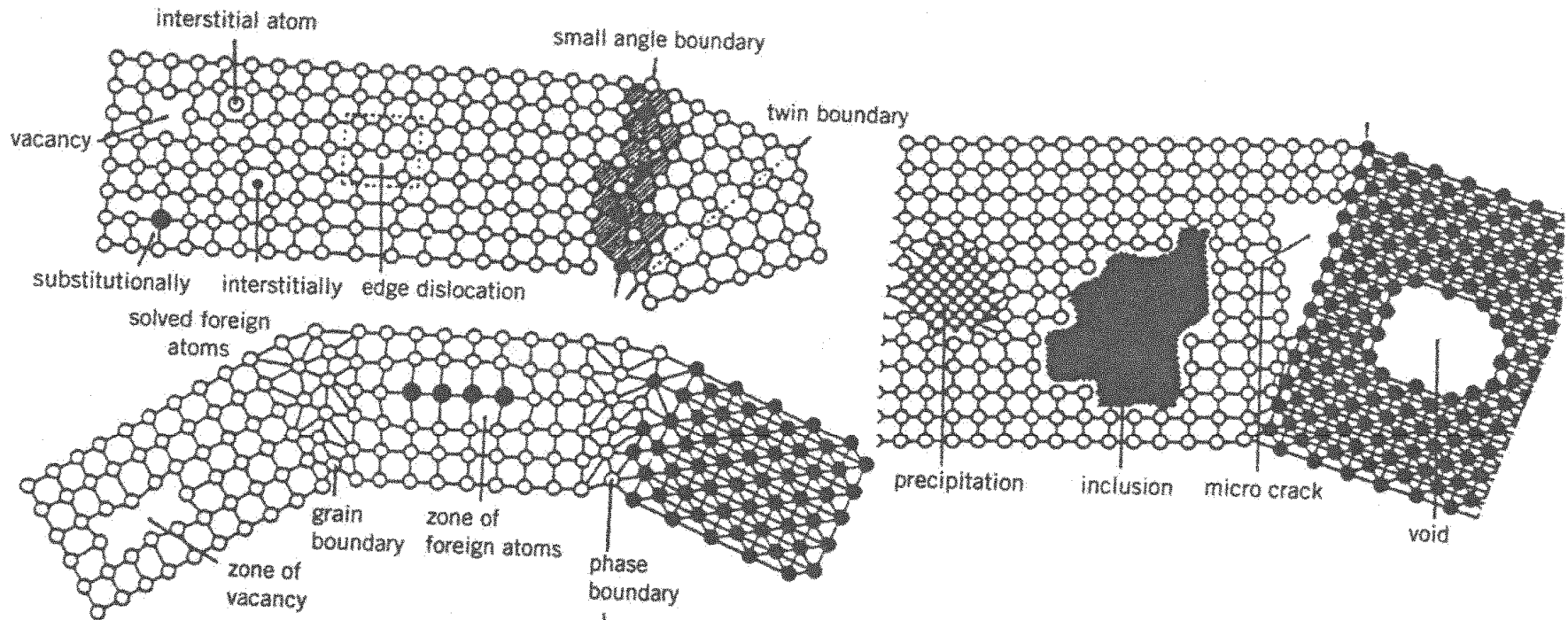


Conclusion

- Even before you get to Donald Rumfelt's 'unknown unknowns' there are plenty of 'known knowns' and 'known unknowns' to keep us all very busy.

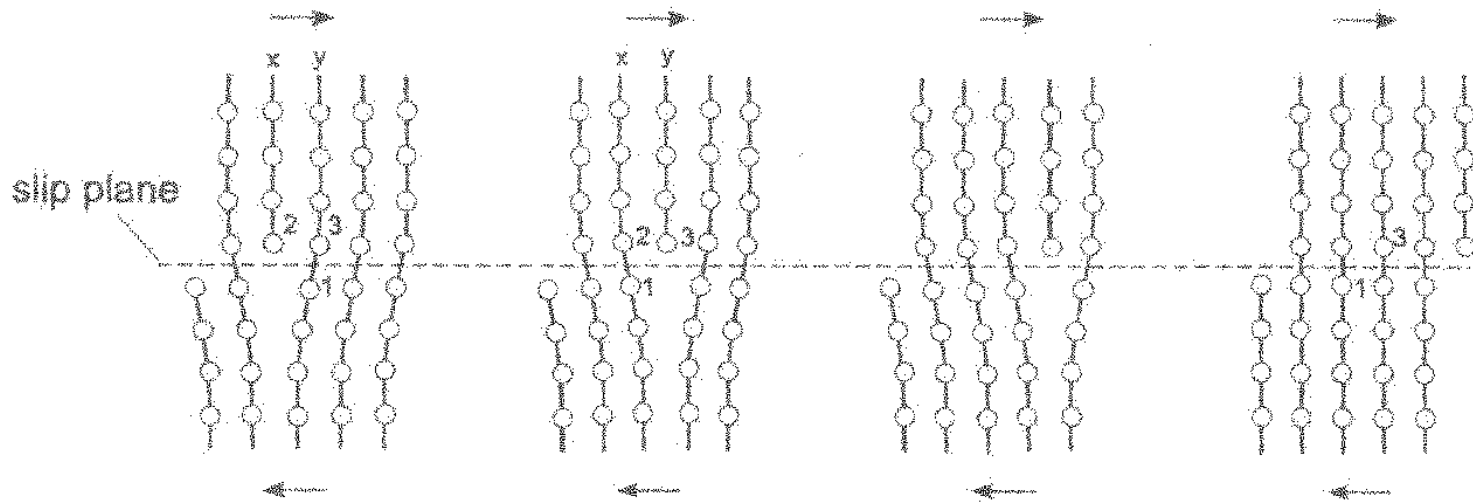
Thankyou

Crystal Defects



- Generation, growth and propagation of defects in crystalline materials play important role in determining macroscopic material properties such as strength
- Purpose of diffraction experiments is to gain insight into material microstructure (particularly defect density) under dynamic loading conditions
- Complements strength measurements made by comparing 2D continuum simulations with experiments looking at Rayleigh-Taylor growth in solid samples (described later).

Dislocation Dynamics and Strength

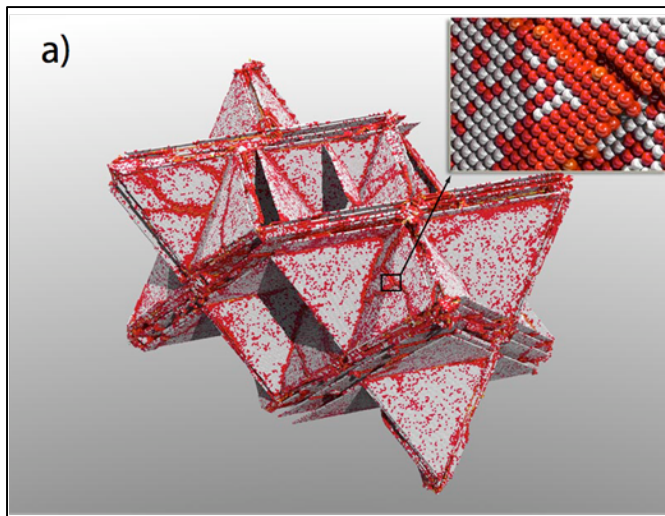


- Dislocations are the fundamental carriers of plastic deformation
- Their density and velocity (mobility) determine $d\varepsilon/dt$ and strength
- Dislocation mobility determined by interactions with other defects encountered as dislocation glides through crystal (other dislocations, point defects, grain boundaries, etc).
- Described by Orowan's equation:

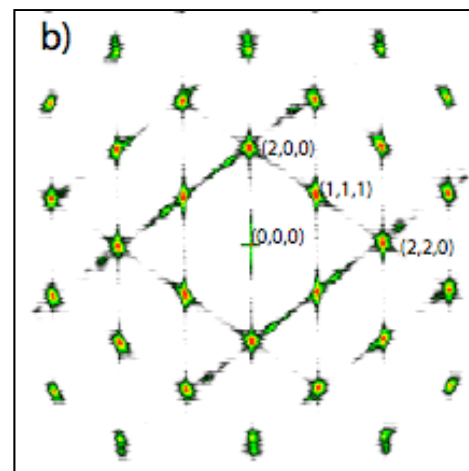
Where $d\varepsilon/dt$ = plastic strain rate, ρ_m = dislocation density,
 b = Burger's vector, v_d = average dislocation velocity

Scientific objective – Make an in situ measurement of defect density and structure in dynamically compressed single crystal materials

- The structural response of a material to deformation is controlled by the formation and motion of defects
- In dynamic situation the predicted dislocation density is predicted to be orders of magnitude higher than observed in recovering
- By looking at the diffuse scattering around Laue diffraction spots using a broadband x-ray source can be used to determine density and structure

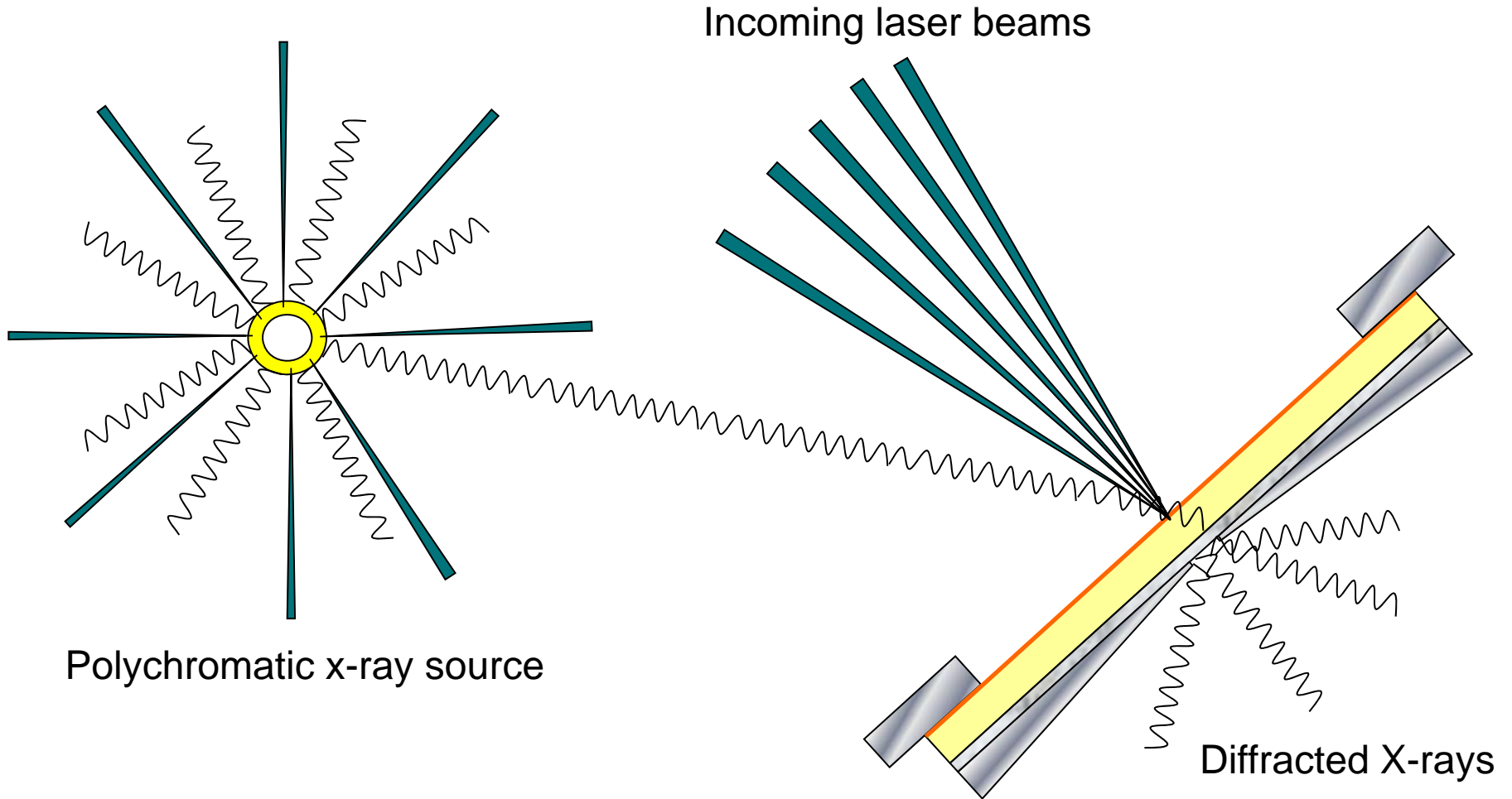


Real space image of defects



Broadening of Diffraction spots due to defects

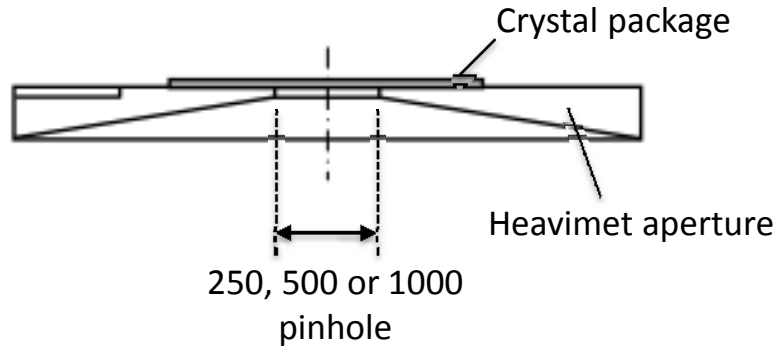
Timing!



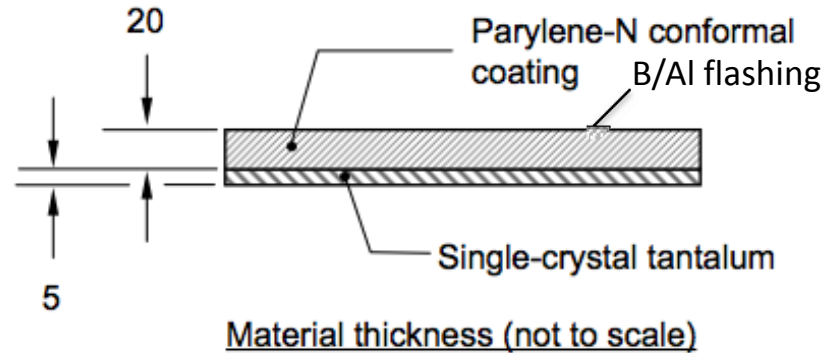


Target and Backlighter

BBXRD-mounted target (dimensions in μm)

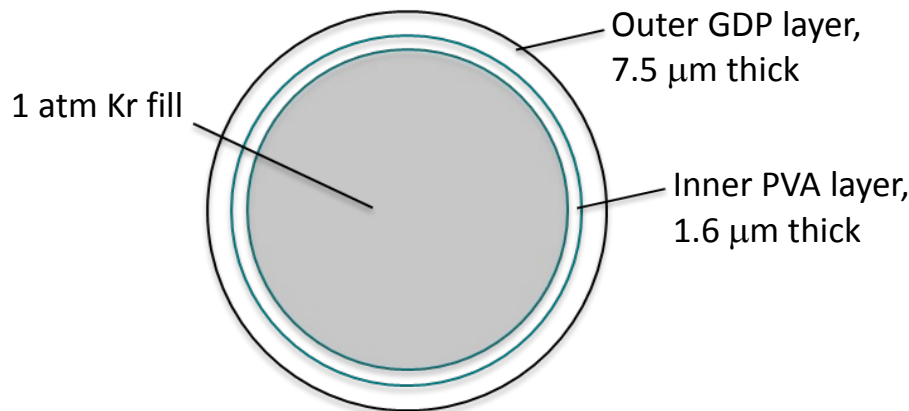


Close-up view of crystal package



Implosion Backlighters (not drawn to scale)

Type 1: 'Dynamic Hohlraum' Capsule, OD 980 μm



Type 2: Single-layer CH capsule, OD 980 μm

